



2814  
#

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Kusumoto et al.

Art Unit : 2814

Serial No. : 09/903,339

Examiner : Theresa T. Doan

Filed : July 10, 2001

Title : METHOD FOR PRODUCING INSULATED GATE THIN FILM  
SEMICONDUCTOR DEVICE

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

TECHNOLOGY CENTER 2800

JUL - 7 2003

RECEIVED

INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of §1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: \_\_\_\_\_

*July 1, 2003*

\_\_\_\_\_  
William G. Hughes, Jr.

Reg. No. 46,112

Fish & Richardson P.C.

1425 K Street, N.W.

11th Floor

Washington, DC 20005-3500

Telephone: (202) 783-5070

Facsimile: (202) 783-2331

WXH/adt

40162589.doc

Substitute Form PTO-1449

U.S. Department of Commerce  
Patent and Trademark Office

Attorney's Docket No.

Application No.

(Modified)

07977-010004

09/903,339

**Information Disclosure Statement  
by Applicant**

(Use several sheets if necessary)

Applicant

Kusumoto et al.

Filing Date

July 10, 2001

Group Art Unit

2814

(37 CFR 1.98(b))

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,569,610	10/29/96	Zhang et al.			
	AB	6,413,805	07/02/02	Zhang et al.			
	AC	6,458,200	10/01/02	Zhang			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	04-37144	07 FEB 1992	JAPAN			Abstract	
	AM	06-267989	22 SEP 1994	JAPAN			Abstract	
	AN	06-318701	15 NOV 1994	JAPAN			Abstract	
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.